

**Notice of References Cited**

Application/Control No.

10/034,669

Applicant(s)/Patent Under  
Reexamination  
SHIBUYA ET AL.

Examiner

Bernard Dentz

Art Unit

1625

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,886,191	03-1999	Dominguez et al	548/490
	B	US-			
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	D	US-			
	E	US-			
	F	US-			
	G	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

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	U	Czarnocka-Janowicz et al, Acta Poloniae (1979) 36(15) p.529-537
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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